

FST3126 Quad Bus Switch

General Description

The Fairchild Switch FST3126 provides four high-speed CMOS TTL-compatible bus switches. The low on resistance of the switch allows inputs to be connected to outputs without adding propagation delay or generating additional ground bounce noise.

The device is organized as four 1-bit switches with separate OE inputs. When OE is HIGH, the switch is ON and Port A is connected to Port B. When OE is LOW, the switch is OPEN and a high-impedance state exists between the two ports.

Features

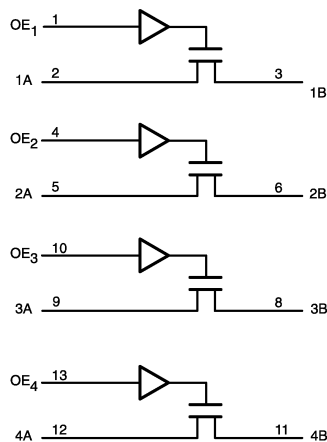
- 4Ω switch connection between two ports.
- Minimal propagation delay through the switch.
- Low I_{CC} .
- Zero bounce in flow-through mode.
- Control inputs compatible with TTL level.

Ordering Code:

Order Number	Package Number	Package Description
FST3126M	M14A	14-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-120, 0.150 Narrow
FST3126QSC	MQA16	16-Lead Quarter Size Outline Package (QSOP), JEDEC MO-137, 0.150 Wide
FST3126MTC	MTC14	14-Lead Thin Shrink Small Outline Package (TSSOP), JEDEC MO-153, 4.4mm Wide

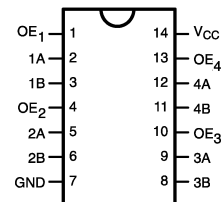
Devices also available in Tape and Reel. Specify by appending the suffix letter "X" to the ordering code.

Logic Diagram

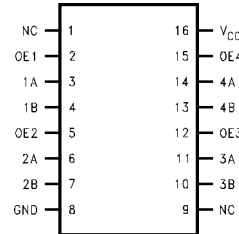


Connection Diagrams

Pin Assignment for SOIC and TSSOP



Pin Assignment for QSOP



Pin Descriptions

Pin Name	Description
OE ₁ , OE ₂ , OE ₃ , OE ₄	Bus Switch Enables
1A, 2A, 3A, 4A	Bus A
1B, 2B, 3B, 4B	Bus B
NC	Not Connected

Truth Table

Inputs	Inputs/Outputs
OE	A, B
L	Z
H	A = B

Absolute Maximum Ratings(Note 1)

Supply Voltage (V_{CC})	–0.5V to +7.0V
DC Switch Voltage (V_S)	–0.5V to +7.0V
DC Input Voltage (V_{IN}) (Note 2)	–0.5V to +7.0V
DC Input Diode Current (I_{IK}) $V_{IN} < 0V$	–50mA
DC Output (I_{OUT}) Sink Current	128mA
DC V_{CC} /GND Current (I_{CC}/I_{GND})	+/- 100mA
Storage Temperature Range (T_{STG})	–65°C to +150 °C

Recommended Operating Conditions (Note 3)

Power Supply Operating (V_{CC})	4.0V to 5.5V
Input Voltage (V_{IN})	0V to 5.5V
Output Voltage (V_{OUT})	0V to 5.5V
Input Rise and Fall Time (t_r, t_f)	
Switch Control Input	0nS/V to 5nS/V
Switch I/O	0nS/V to DC
Free Air Operating Temperature (T_A)	–40 °C to +85 °C

Note 1: The "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. The device should not be operated at these limits. The parametric values defined in the Electrical Characteristics tables are not guaranteed at the absolute maximum rating. The "Recommended Operating Conditions" table will define the conditions for actual device operation.

Note 2: The input and output negative voltage ratings may be exceeded if the input and output diode current ratings are observed.

Note 3: Unused control inputs must be held high or low. They may not float.

DC Electrical Characteristics

Symbol	Parameter	V_{CC} (V)	$T_A = -40\text{ °C to }+85\text{ °C}$			Units	Conditions
			Min	Typ (Note 4)	Max		
V_{IK}	Clamp Diode Voltage	4.5			–1.2	V	$I_{IN} = -18\text{mA}$
V_{IH}	HIGH Level Input Voltage	4.0–5.5	2.0			V	
V_{IL}	LOW Level Input Voltage	4.0–5.5			0.8	V	
I_I	Input Leakage Current	5.5			±1.0	μA	$0 \leq V_{IN} \leq 5.5V$
I_{OZ}	OFF-STATE Leakage Current	5.5			±1.0	μA	$0 \leq A, B \leq V_{CC}$
R_{ON}	Switch On Resistance (Note 5)	4.5		4	7	Ω	$V_{IN} = 0V, I_{IN} = 64\text{mA}$
		4.5		4	7	Ω	$V_{IN} = 0V, I_{IN} = 30\text{mA}$
		4.5		8	15	Ω	$V_{IN} = 2.4V, I_{IN} = 15\text{mA}$
		4.0		11	20	Ω	$V_{IN} = 2.4V, I_{IN} = 15\text{mA}$
I_{CC}	Quiescent Supply Current	5.5			3	μA	$V_{IN} = V_{CC}$ or GND, $I_{OUT} = 0$
ΔI_{CC}	Increase in I_{CC} per Input	5.5			2.5	mA	One input at 3.4V. Other inputs at V_{CC} or GND

Note 4: Typical values are at $V_{CC} = 5.0V$ and $T_A = +25\text{°C}$

Note 5: Measured by the voltage drop between A and B pins at the indicated current through the switch. On resistance is determined by the lower of the voltages on the two (A or B) pins.

AC Electrical Characteristics

Symbol	Parameter	T _A = -40 °C to +85 °C, C _L = 50pF, R _U = R _D = 500Ω				Units	Conditions	Figure No.
		V _{CC} = 4.5 – 5.5V		V _{CC} = 4.0V				
		Min	Max	Min	Max			
t _{PHL} , t _{PLH}	Prop Delay Bus to Bus (Note 6)		0.25		0.25	ns	V _I =OPEN	Figure 1 Figure 2
t _{PZH} , t _{PZL}	Output Enable Time	1.0	4.5		5.0	ns	V _I = 7V for t _{PZL} V _I = OPEN for t _{PZH}	Figure 1 Figure 2
t _{PHZ} , t _{PLZ}	Output Disable Time	1.5	5.7		6.2	ns	V _I = 7V for t _{PLZ} V _I = OPEN for t _{PHZ}	Figure 1 Figure 2

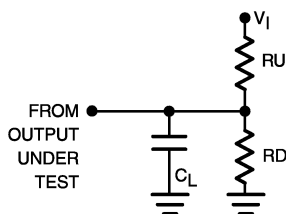
Note 6: This parameter is guaranteed by design but is not tested. The bus switch contributes no propagation delay other than the RC delay of the typical On resistance of the switch and the 50pF load capacitance, when driven by an ideal voltage source (zero output impedance).

Capacitance (Note 7)

Symbol	Parameter	Typ	Max	Units	Conditions
C_{IN}	Control Pin Input Capacitance	3		pF	$V_{CC} = 5.0\text{V}$
$C_{I/O}$	Input/Output Capacitance	5		pF	$V_{CC} = 5.0\text{V}$, $OE = 0\text{V}$

Note 7: $T_A = +25\text{ }^{\circ}\text{C}$, $f = 1\text{ MHz}$, Capacitance is characterized but not tested.

AC Loading and Waveforms



Note: Input driven by 50 Ω source terminated in 50 Ω

Note: C_L includes load and stray capacitance

Note: Input PRR = 1.0MHz, $t_W = 500\text{ns}$

FIGURE 1. AC Test Circuit

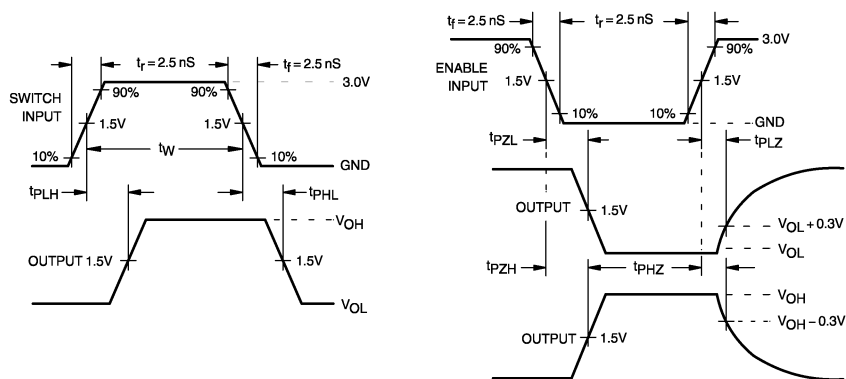
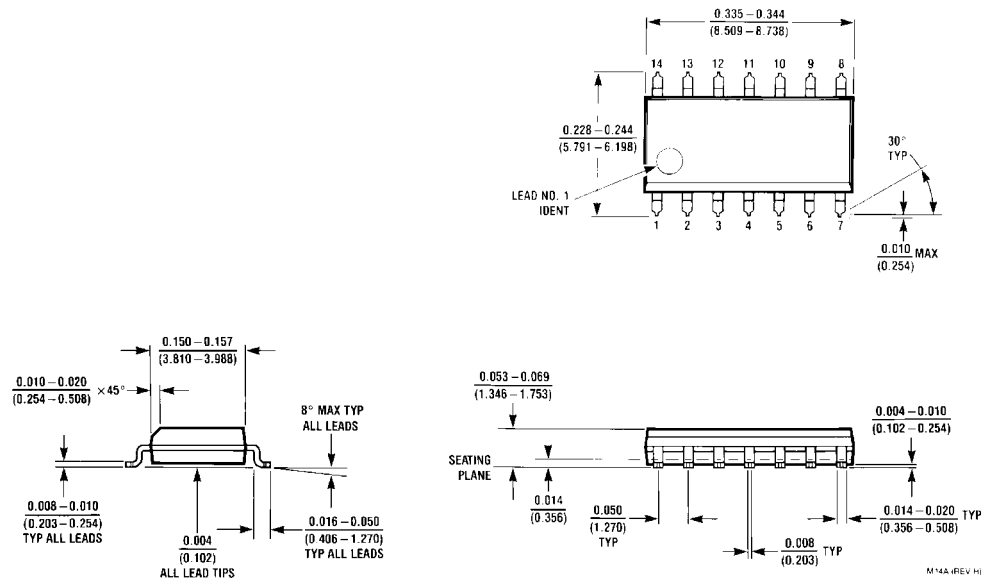
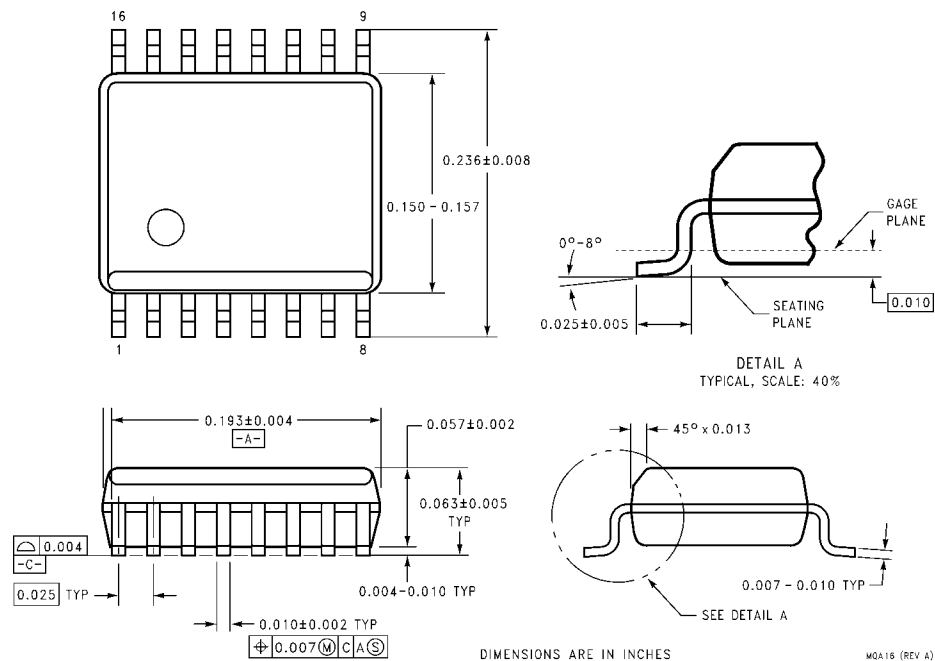


FIGURE 2. AC Waveforms

Physical Dimensions inches (millimeters) unless otherwise noted

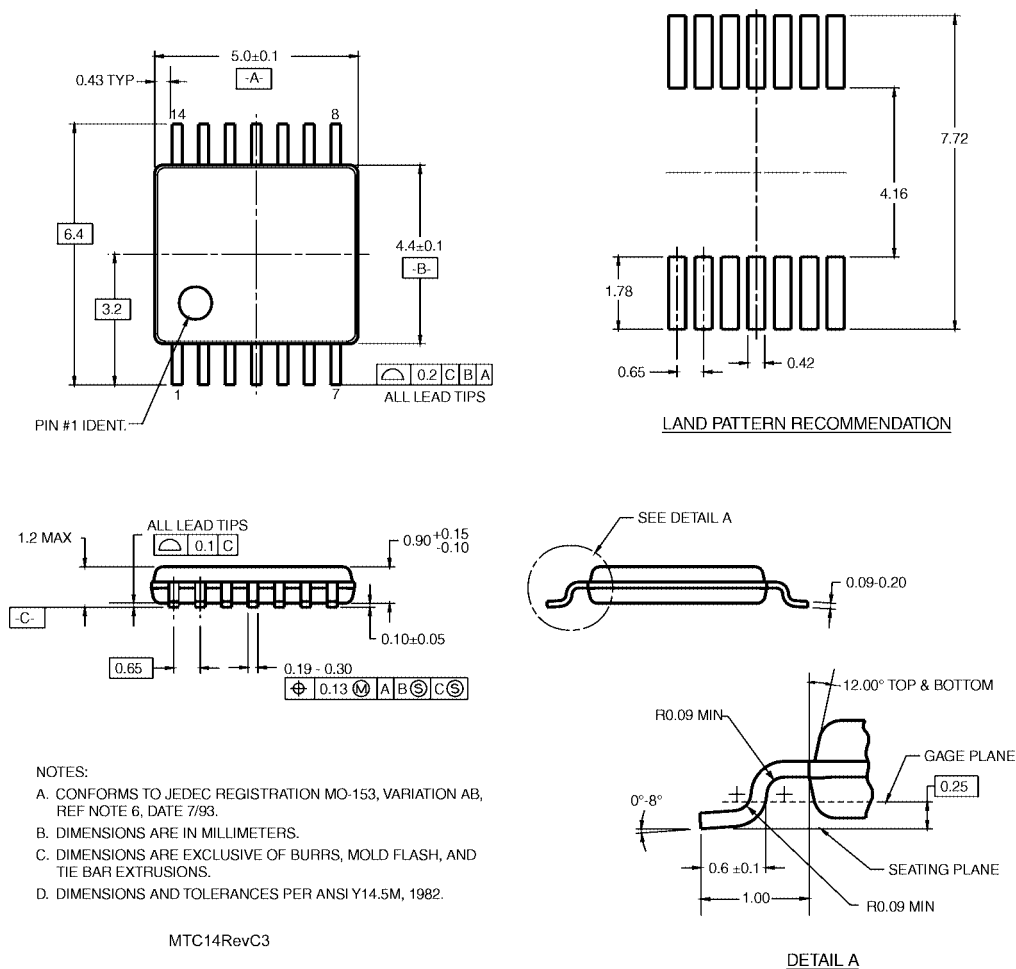


14-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-120, 0.150 Narrow Package Number M14A



16-Lead Quarter Size Outline Package (QSOP), JEDEC MO-137, 0.150 Wide Package Number MQA16

Physical Dimensions inches (millimeters) unless otherwise noted (Continued)



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